



18-BIT, 500-kHz, UNIPOLAR INPUT, MICROPOWER SAMPLING ANALOG-TO-DIGITAL CONVERTER WITH PARALLEL INTERFACE

FEATURES

- 500-kHz Sample Rate
- 18-Bit NMC Ensured Over Temperature
- Zero Latency
- Low Power: 110 mW at 500 kHz
- Unipolar Input Range
- Onboard Reference Buffer
- High-Speed Parallel Interface
- Wide Digital Supply
- 8-/16-/18-Bit Bus Transfer
- 48-Pin TQFP Package

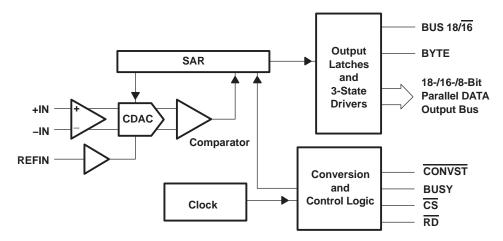
APPLICATIONS

- Medical Instruments
- Optical Networking
- Transducer Interface
- High Accuracy Data Acquisition Systems
- Magnetometers

DESCRIPTION

The ADS8383 is an 18-bit, 500 kHz A/D converter. The device includes a 18-bit capacitor-based SAR A/D converter with inherent sample and hold. The ADS8383 offers a full 18-bit interface, a 16-bit option where data is read using two read cycles or an 8-bit bus option using three read cycles.

The ADS8383 is available in a 48-lead TQFP package and is characterized over the industrial -40° C to 85° C temperature range.





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

ADS8383



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ORDERING INFORMATION

MODEL	MAXIMUM INTEGRAL LINEARITY (LSB)	MAXIMUM DIFFERENTIAL LINEARITY (LSB)	NO MISSING CODES RESOLU- TION (BIT)	PACKAGE TYPE	PACKAGE DESIGNATOR	TEMPER- ATURE RANGE	ORDERING INFORMATION	TRANS- PORT MEDIA QUANTITY					
	140	0.7	47	48 Pin PFB -40°C to TOFP PFB 85°C	48 Pin	48 Pin	48 Pin	48 Pin	48 Pin	252	−40°C to	ADS8383IPFBT	Tape and reel 250
ADS8383I	±10	-2~7	17		PER	FFD	FTD	FTD	85°C	85°C	ADS8383IPFBR	Tape and reel 1000	
	. =	4.05	10	48 Pin	48 Pin		–40°C to	ADS8383IBPFBT	Tape and reel 250				
ADS8383IB	±7	-1~2.5	18	TQFP			ADS8383IBPFBR	Tape and reel 1000					

NOTE: For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted⁽¹⁾

			UNIT	
+IN to AGND			-0.4 V to +VA + 0.1 V	
Voltage	-IN to AGND		–0.4 V to 0.5 V	
	+VA to AGND		–0.3 V to 7 V	
Voltage	+VBD to BDGND		–0.3 V to 7 V	
	+VA to +VBD		–0.3 V to 2.5 V	
Digital input voltage	e to BDGND		-0.3 V to +VBD + 0.3 V	
Digital output volta	Digital output voltage to BDGND			
Operating free-air t	emperature range, 7	Α	-40°C to 85°C	
Storage temperatu	re range, T _{stg}		–65°C to 150°C	
Junction temperatu	ıre (TJ max)		150°C	
	Power dissipation		(Τ _J Max – Τ _Α)/θ _{JA}	
TQFP package	θ _{JA} thermal imped	ance	86°C/W	
		Vapor phase (60 sec)	215°C	
Lead temperature,	soldering	Infrared (15 sec)	220°C	

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. INSTRUMENTS www.ti.com

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SPECIFICATIONS

T_A = -40°C to 85°C, +VA = 5 V, +VBD = 3 V or 5 V, V_{ref} = 4.096 V, f_{SAMPLE} = 500 kHz (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Analog Input						
Full-scale input voltage (see Note 1)		+IN – –IN	0		Vref	V
		+IN	-0.2		V _{ref} + 0.2	
Absolute input voltage		-IN	-0.2		0.2	V
Input capacitance				45		pF
Input leakage current				1		nA
System Performance						
Resolution				18		Bits
	40000001	(+IN – −IN) < 0.5 FS	17			
No missing codes	ADS8383I	(+IN – –IN) ≥ 0.5 FS	17			Bits
	ADS8383IB		18			
Integral linearity (see Notes 2 and 3)		(+IN – −IN) < 0.125 FS	-4		4	
	ADS8383I	(+IN – −IN) < 0.5 FS	-6		6	LSB (18 bit)
		(+IN – –IN) ≥ 0.5 FS	-10		10	
	ADS8383IB		-7	-2/3	7	
		(+IN – −IN) < 0.125 FS	-1		2	
	ADS8383I	(+IN – −IN) < 0.5 FS	-1		3	
Differential linearity		$(+ININ) \ge 0.5 FS$	-2		7	LSB (18 bit
	ADS8383IB		-1	-1/1.4	2.5	
	ADS8383I		-1	±0.5	1	
Offset error (see Note 4)	ADS8383IB		-0.75	±0.25	0.75	mV
	ADS8383I	V _{ref} = 4.096 V	-0.1		0.1	%FS
Gain error (see Note 4)	ADS8383IB	V _{ref} = 4.096 V	-0.06		0.06	%FS
Noise				60		μV RMS
Power supply rejection ratio		At 3FFFFh output code		75		dB
Sampling Dynamics						
Conversion time					1.52	μs
Acquisition time			0.4			μs
Throughput rate					500	kHz
Aperture delay				4		ns
Aperture jitter				15		ps
Step response				150		ns
Over voltage recovery				150		ns

(1) Ideal input span, does not include gain or offset error.
(2) LSB means least significant bit
(3) This is endpoint INL, not best fit.
(4) Measured relative to an ideal full-scale input (+IN – –IN) of 4.096 V



SPECIFICATIONS (CONTINUED) $T_A = -40^{\circ}C$ to 85°C, +VA = +5 V, +VBD = 3 V or 5 V, V_{ref} = 4.096 V, f_{SAMPLE} = 500 kHz (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Dynamic Characteristics	- 1					
	ADS8383I	VIN = 4 V _{pp} at 1 kHz		-110		
	ADS8383IB		-112			
	ADS8383I	VIN = 4 V _{pp} at 10 kHz		-98		
Total harmonic distortion (THD)	ADS8383IB			-108		dB
(see Note 1)	ADS8383I	-1/1 = 4/1 = 150 kHz		-98		uD
	ADS8383IB	V _{IN} = 4 V _{pp} at 50 kHz		-99		
	ADS8383I	VIN = 4 V _{pp} at 100 kHz		-90		
	ADS8383IB			-91		
	ADS8383I			87		
	ADS8383IB	V _{IN} = 4 V _{pp} at 1 kHz		88		
	ADS8383I			87		
Signal to poice ratio (SNR) (and Note 1)	ADS8383IB	V _{IN} = 4 V _{pp} at 10 kHz		87		dB
Signal to noise ratio (SNR) (see Note 1)	ADS8383I			87		uБ
	ADS8383IB	V _{IN} = 4 V _{pp} at 50 kHz		87		
	ADS8383I			87		
	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 100 kHz		87		
	ADS8383I			86		
	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 1 kHz		87		
	ADS8383I			86		
Signal to noise + distortion (SINAD)	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 10 kHz		86		
(see Note 1)	ADS8383I			86		dB
	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 50 kHz		86		
	ADS8383I			85		
	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 100 kHz		85		
	ADS8383I			110		
	ADS8383IB	V _{IN} = 4 V _{pp} at 1 kHz		112		
	ADS8383I			98		
Spurious free dynamic range (SFDR)	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 10 kHz		108		
(see Note 1)	ADS8383I			98		dB
	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 50 kHz		98		
	ADS8383I			90		
	ADS8383IB	$V_{IN} = 4 V_{pp}$ at 100 kHz		94		
–3dB Small signal bandwidth	•			3		MHz
Voltage Reference Input						
Reference voltage at REFIN, Vref			2.5	4.096	4.2	V
Reference resistance (see Note 2)				500		kΩ
Reference current drain		f _S = 500 kHz			1	mA
Bias Input						
Bias input range			2	2.048	2.1	V
Bias input drift					±5	%FS
Bias input current, sink			-150	-100		μA

(1) Calculated on the first nine harmonics of the input frequency (2) Can vary $\pm 20\%$

SPECIFICATIONS (CONTINUED)

 $T_A = -40^{\circ}C$ to 85°C, +VA = +5 V, +VBD = 3 V or 5 V, $V_{ref} = 4.096$ V, $f_{SAMPLE} = 500$ kHz (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Digital Input/Output						
Logic family				CMOS		
	VIH	I _{IH} = 5 μA	+VBD-1		+V _{BD} + 0.3	
Logic level	VIL	I _{IL} = 5 μA	-0.3		0.8	.,
	V _{OH}	I _{OH} = 2 TTL loads	+V _{BD} - 0.6			V
	V _{OL}	$I_{OL} = 2 TTL loads$			0.4	
Data format				Straight Binary		
Power Supply Requir	rements					
	+VBD (see Notes 1 and 2)		2.95	3.3	5.25	V
Power supply voltage	+VA (see Note 2)		4.75	5	5.25	V
Supply current, 500-kH	Iz sample rate (see Note 3)			22	26	mA
Power dissipation, 500)-kHz sample rate (see Note 3)			110	130	mW
Temperature Range			•			
Operating free-air			-40		85	°C

(1) The difference between +VA and +VBD should be no less than 2.3 V, i.e. if +VA is 5.5 V, +VBD should be at least 2.95 V.

(2) $+VBD \ge +VA - 2.3 V$

(3) This includes only +VA current. +VBD current is typical 1 mA with 5 pF load capacitance on all output pins.



TIMING CHARACTERISTICS

All specifications typical at -40° C to 85° C, +VA = +VBD = 5 V (see Notes 1, 2, and 3)

	PARAMETER	MIN	TYP	MAX	UNIT
^t CONV	Conversion time			1.52	μs
^t ACQ	Acquisition time	0.4			μs
^t HOLD	Hold time, sampling capacitor			25	ns
^t pd1	Propagation delay time, CONVST low to conversion started (BUSY high)			45	ns
^t pd2	Propagation delay time, end of conversion to BUSY low			20	ns
^t pd3	Propagation delay time, from start of CONVERT state to rising edge of BUSY			20	ns
tw1	Pulse duration, CONVST low	40			ns
^t su1	Setup time, CS low to CONVST low	20			ns
t _{w2}	Pulse duration, CONVST high	20			ns
	CONVST falling edge jitter			10	ps
t _{w3}	Pulse duration, BUSY low	Min(tACQ)			μs
t _{w4}	Pulse duration, BUSY high			1.52	μs
^t h1	Hold time, first data bus data transition (RD low, or CS low for read cycle, or BYTE or BUS18/16 input changes) after CONVST low	40			ns
^t d1	Delay time, CS low to RD low	0			ns
t _{su2}	Setup time, RD high to CS high	0			ns
tw5	Pulse duration, RD low	50			ns
t _{en}	Enable time, \overline{RD} low (or \overline{CS} low for read cycle) to data valid			20	ns
td2	Delay time, data hold from RD high	5			ns
td3	Delay time, BUS18/16 or BYTE rising edge or falling edge to data valid	10		20	ns
t _{w6}	Pulse duration, RD high	20			ns
t _{w7}	Pulse duration, CS high	20			ns
^t h2	Hold time, last RD (or CS for read cycle) rising edge to CONVST falling edge	125			ns
tpd4	Propagation delay time, BUSY falling edge to next RD (or CS for read cycle) falling edge	Max(t _{d5})			ns
t _{d4}	Delay time, BYTE edge to BUS18/16 edge skew	0			ns
t _{su3}	Setup time, BYTE or BUS18/16 transition to RD falling edge	10			ns
t _{h3}	Hold time, BYTE or BUS18/16 transition to RD falling edge	10			ns
^t dis	Disable time, RD High (CS high for read cycle) to 3-stated data bus			20	ns
td5	Delay time, BUSY low to MSB data valid			30	ns
-	Setup time, BYTE transition to next BYTE transition, or BUS18/16 to next BUS18/16	50			

(1) All input signals are specified with $t_f = t_f = 5$ ns (10% to 90% of +VBD) and timed from a voltage level of (V_{IL} + V_{IH})/2. (2) See timing diagrams.

(3) All timing are measured with 20 pF equivalent loads on all data bits and BUSY pins.

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TIMING CHARACTERISTICS

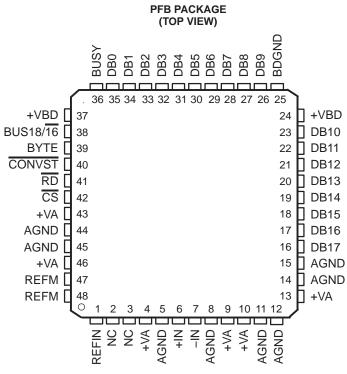
All specifications typical at -40° C to 85° C, +VA = 5 V, +VBD = 3 V (see Notes 1, 2, and 3)

	PARAMETER	MIN	TYP	MAX	UNIT
^t CONV	Conversion time			1.52	μs
^t ACQ	Acquisition time	0.4			μs
^t HOLD	Hold time, sampling capacitor			25	ns
^t pd1	Propagation delay time, CONVST low to conversion started (BUSY high)			50	ns
tpd2	Propagation delay time, end of conversion to BUSY low			25	ns
^t pd3	Propagation delay time, start of CONVERT state to rising edge of BUSY			25	ns
tw1	Pulse duration, CONVST low	40			ns
t _{su1}	Setup time, CS low to CONVST low	20			ns
t _{w2}	Pulse duration, CONVST high	20			ns
	CONVST falling edge jitter			10	ps
t _{w3}	Pulse duration, BUSY low	Min(tACQ)			μs
t _{w4}	Pulse duration, BUSY high			1.52	μs
^t h1	Hold time, first data bus transition (RD low, or CS low for read cycle, or BYTE or BUS 18/16 input changes) after CONVST low	40			ns
^t d1	Delay time, CS low to RD low	0			ns
t _{su2}	Setup time, RD high to CS high	0			ns
t _{w5}	Pulse duration, RD low	50			ns
ten	Enable time, RD low (or CS low for read cycle) to data valid			30	ns
td2	Delay time, data hold from RD high	10			ns
td3	Delay time, BUS18/16 or BYTE rising edge or falling edge to data valid	10		30	ns
tw6	Pulse duration, RD high	20			ns
t _{w7}	Pulse duration, CS high	20			ns
^t h2	Hold time, last RD (or CS for read cycle) rising edge to CONVST falling edge	125			ns
^t pd4	Propagation delay time, BUSY falling edge to next RD (or CS for read cycle) falling edge	Max(td5)			ns
t _{d4}	Delay time, BYTE edge to BUS18/16 edge skew	0			ns
t _{su3}	Setup time, BYTE or BUS18/16 rising edge to RD falling edge	10			ns
t _{h3}	Hold time, BYTE or BUS18/16 falling edge to RD falling edge	10			ns
^t dis	Disable time, RD High (CS high for read cycle) to 3-stated data bus			30	ns
td5	Delay time, BUSY low to MSB data valid delay time			40	ns
t _{su5}	Setup time, from BYTE transition to next BYTE transition or from $BUS18/\overline{16}$ to next $BUS18/\overline{16}$	50			ns

(1) All input signals are specified with $t_r = t_f = 5$ ns (10% to 90% of +VBD) and timed from a voltage level of (V_{IL} + V_{IH})/2. (2) See timing diagrams. (3) All timing are measured with 10 pF equivalent loads on all data bits and BUSY pins.



PIN ASSIGNMENTS

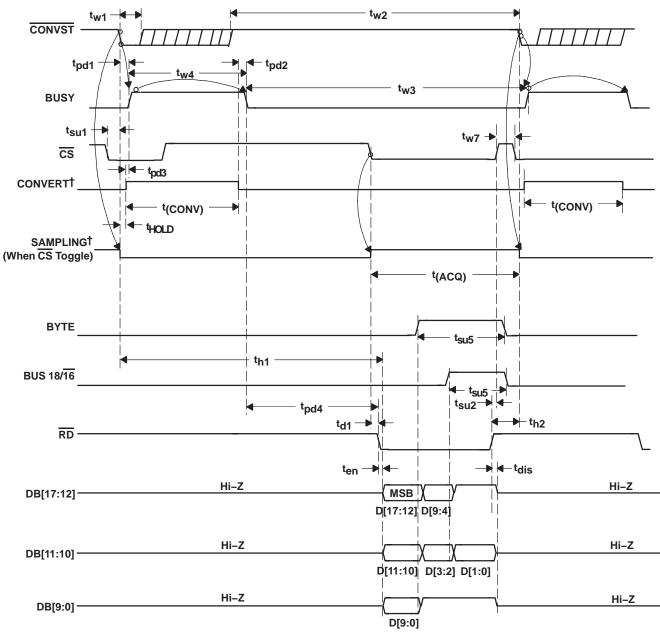


NC - No connection.

TERMINAL FUNCTIONS

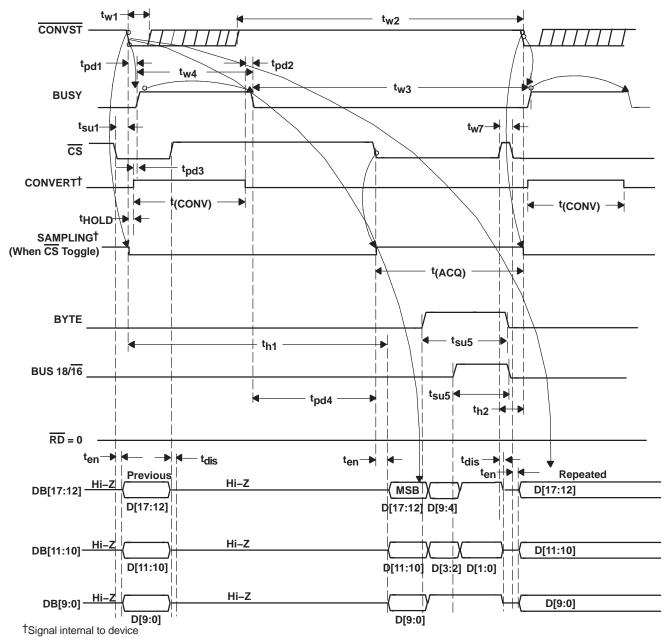
NAME	NO.	I/O			DESCR				
AGND	5, 8, 11, 12, 14, 15, 44, 45	_	Analog ground	nalog ground					
BDGND	25	-	Digital ground fo	or bus interface di	gital supply				
BUSY	36	0	Status output. H	igh when a conve	ersion is in progre	SS.			
BUS18/16	38	I	0: Data bits outp 1: Last two data a) the	s size select input. Used for selecting 18-bit or 16-bit wide bus transfer. Data bits output on the 18-bit data bus pins DB[17:0]. .ast two data bits D[1:0] from 18-bit wide bus output on: a) the low byte pins DB[9:2] if BYTE = 0 b) the high byte pins DB[17:10] if BYTE = 1					
BYTE	39	I	0: No fold back	t. Used for 8-bit b 2] of the 16 mos	us reading. t significant bits is	folded back to h	igh byte of the 16	most significant	
CONVST	40	1	Convert start. Th	ne falling edge of	this input ends th	e acquisition perio	od and starts the	hold period.	
CS	42	I	Chip select. The	falling edge of th	is input starts the	acquisition perio	d		
				8-Bit Bus		16-B	it Bus	18-Bit Bus	
Data Bus			BYTE = 0	BYTE = 1	BYTE = 1	BYTE = 0	BYTE = 0	BYTE = 0	
			BUS18/16 = 0	BUS18/16 = 0	BUS18/16 = 1	BUS18/16 = 0	BUS18/16 = 1	BUS18/16 = 0	
DB17	16	0	D17 (MSB)	D9	All ones	D17 (MSB)	All ones	D17 (MSB)	
DB16	17	0	D16	D8	All ones	D16	All ones	D16	
DB15	18	0	D15	D7	All ones	D15	All ones	D15	
DB14	19	0	D14	D6	All ones	D14	All ones	D14	
DB13	20	0	D13	D5	All ones	D13	All ones	D13	
DB12	21	0	D12	D4	All ones	D12	All ones	D12	
DB11	22	0	D11	D3	D1	D11	All ones	D11	
DB10	23	0	D10	D2	D0(LSB)	D10	All ones	D10	
DB9	26	0	D9	All ones	All ones	D9	All ones	D9	
DB8	27	0	D8	All ones	All ones	D8	All ones	D8	
DB7	28	0	D7	All ones	All ones	D7	All ones	D7	
DB6	29	0	D6	All ones	All ones	D6	All ones	D6	
DB5	30	0	D5	All ones	All ones	D5	All ones	D5	
DB4	31	0	D4	All ones	All ones	D4	All ones	D4	
DB3	32	0	D3	All ones	All ones	D3	D1	D3	
DB2	33	0	D2	All ones	All ones	D2	D0 (LSB)	D2	
DB1	34	0	D1	All ones	All ones	D1	All ones	D1	
DB0	35	0	D0 (LSB)	All ones	All ones	D0 (LSB)	All ones	D0 (LSB)	
–IN	7	Ι	Inverting input c	hannel					
+IN	6	I	Noninverting inp	ut channel					
NC	2, 3	-	No connection						
REFIN	1	I	Reference input						
REFM	47, 48	I	Reference grour	nd.					
RD	41	I	Synchronization	pulse for the para	allel output. Wher	\overline{CS} is low this se	erves as output er	nable.	
+VA	4, 9, 10, 13, 43, 46	-	Analog power su	upplies, 5-V dc					
+VBD	24, 37	-	Digital power su	pply for bus					

TIMING DIAGRAMS



†Signal internal to device

Figure 1. Timing for Conversion and Acquisition Cycles With $\overline{\text{CS}}$ and $\overline{\text{RD}}$ Toggling



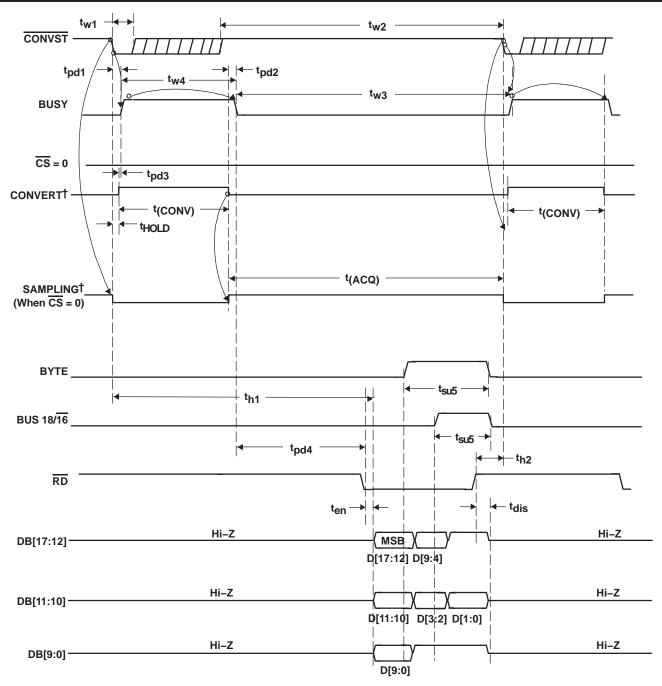
NOTE: RD cannot be tied to BDGND. Three read cycles are required at power on.



ADS8383

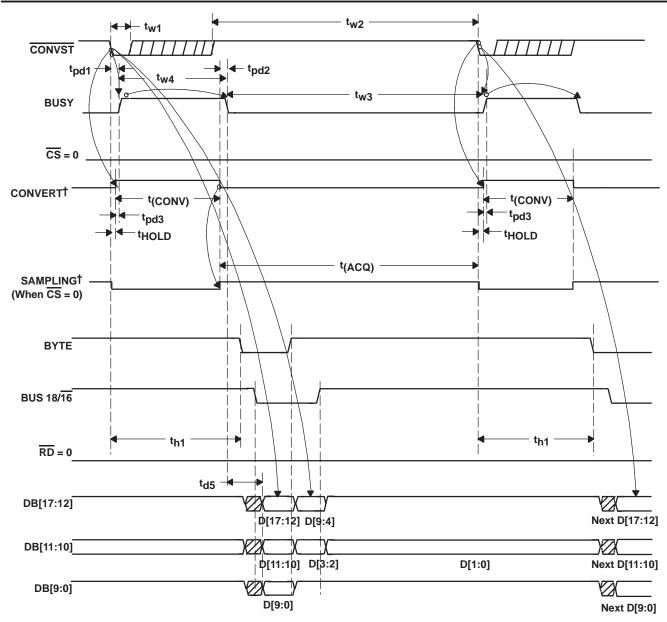


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†Signal internal to device

Figure 3. Timing for Conversion and Acquisition Cycles With CS Tied to BDGND, RD Toggling



†Signal internal to device

NOTE: RD cannot be tied to BDGND. Three read cycles are required at power on.

Figure 4. Timing for Conversion and Acquisition Cycles With CS and RD Held at BDGND After Power-On Initialization - Auto Read

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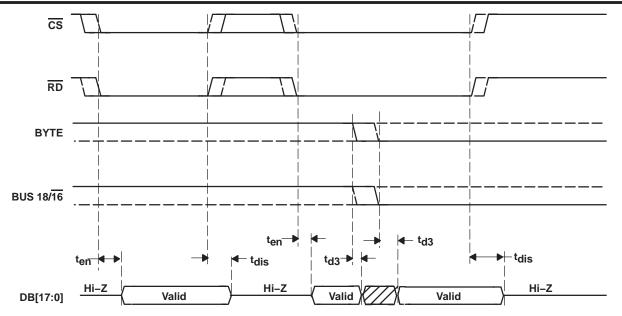
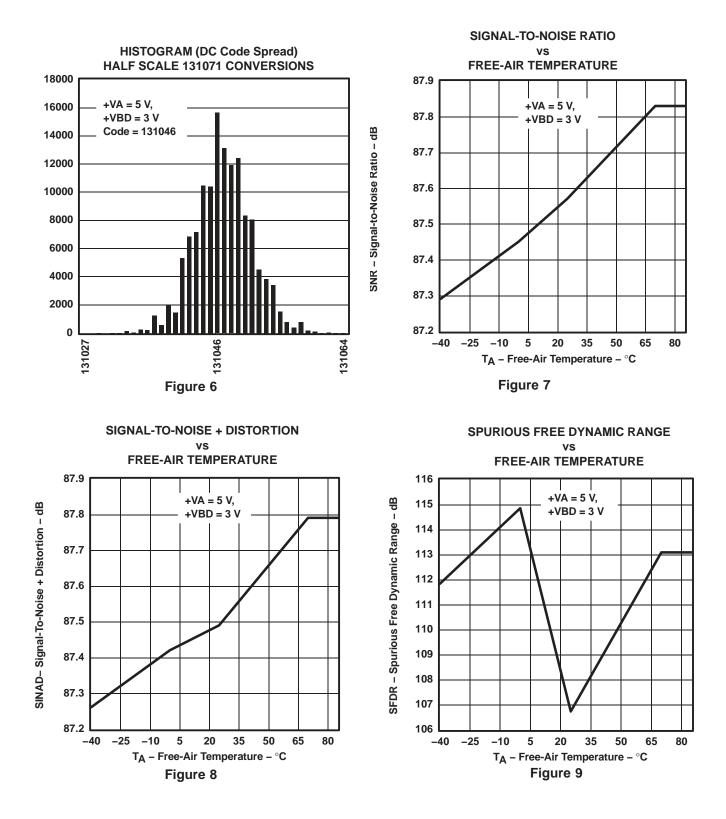
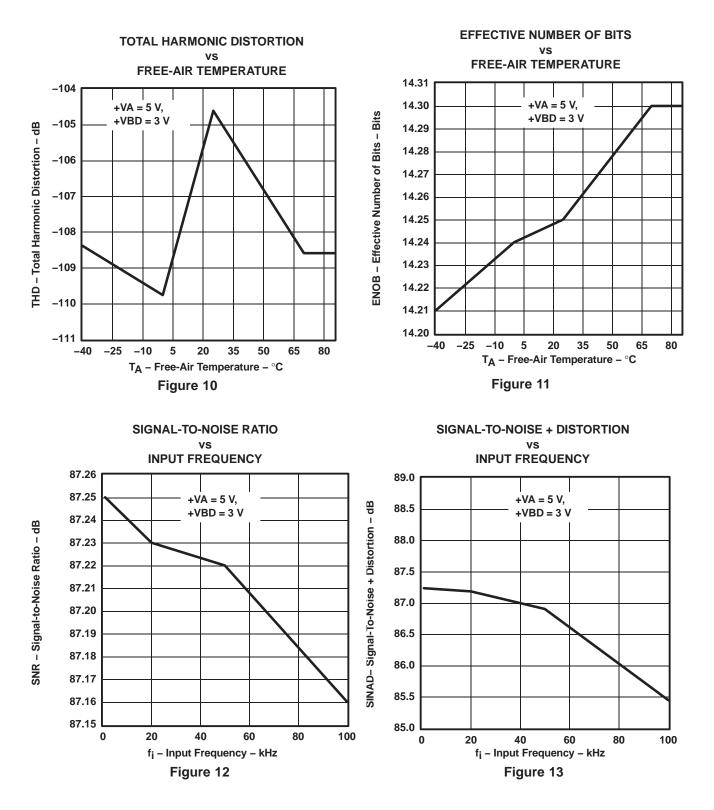


Figure 5. Detailed Timing for Read Cycles



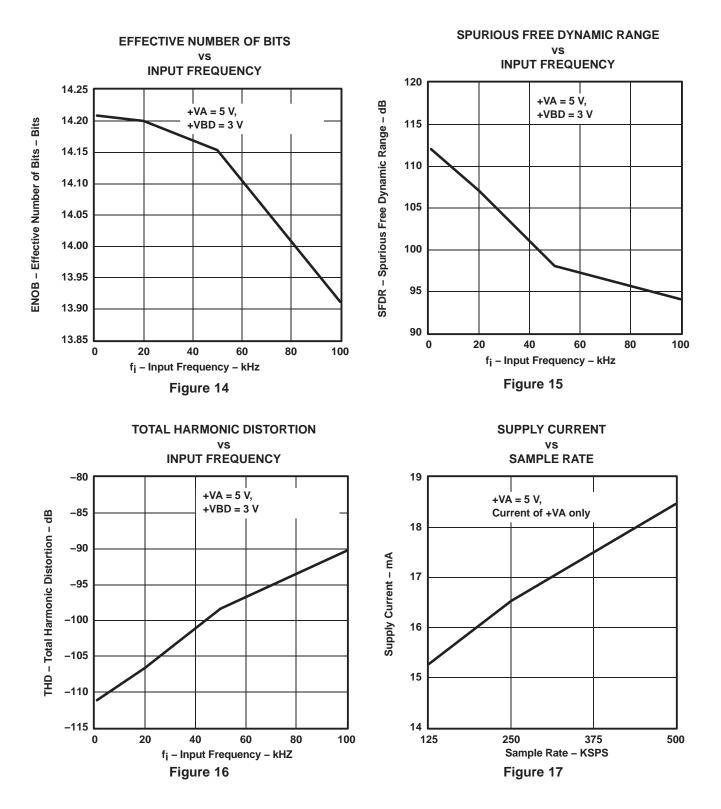


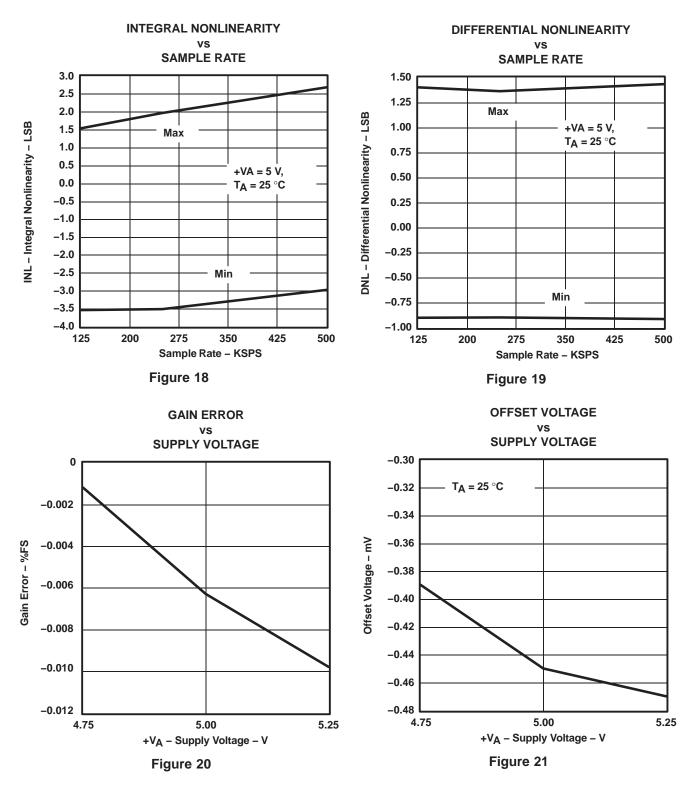


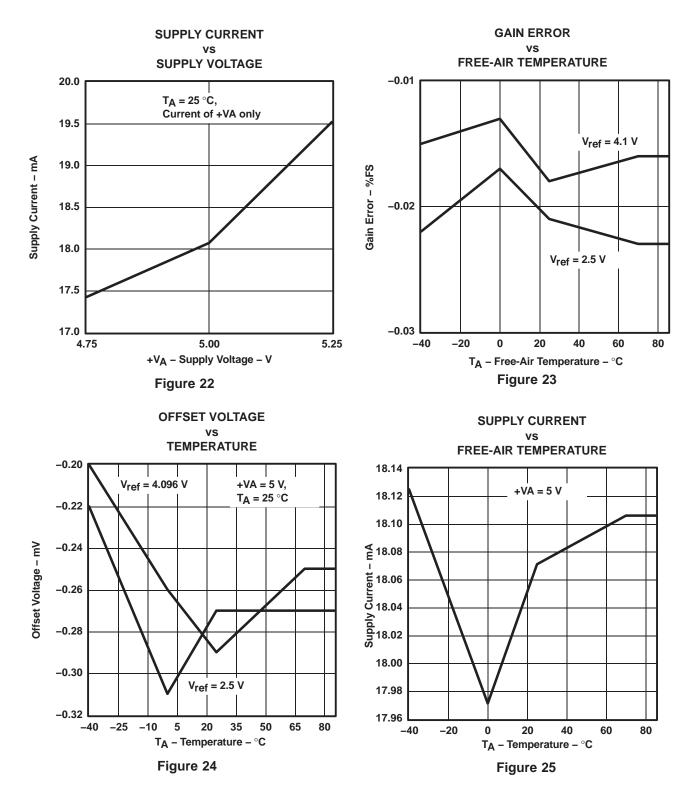


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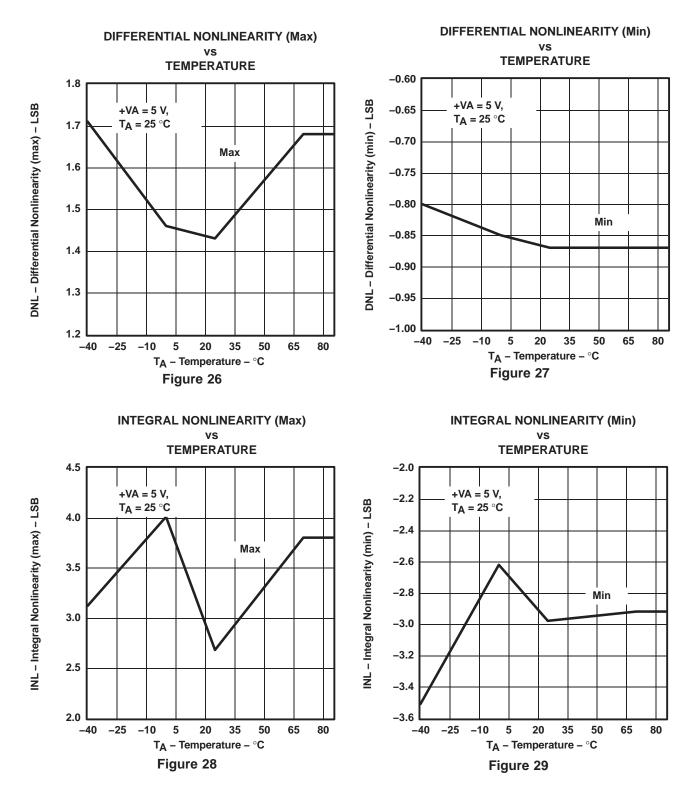
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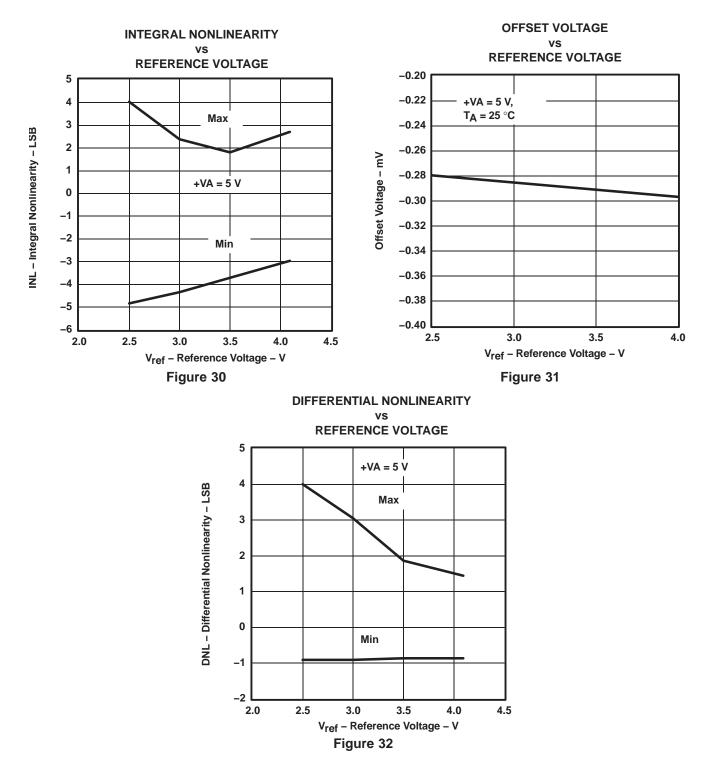








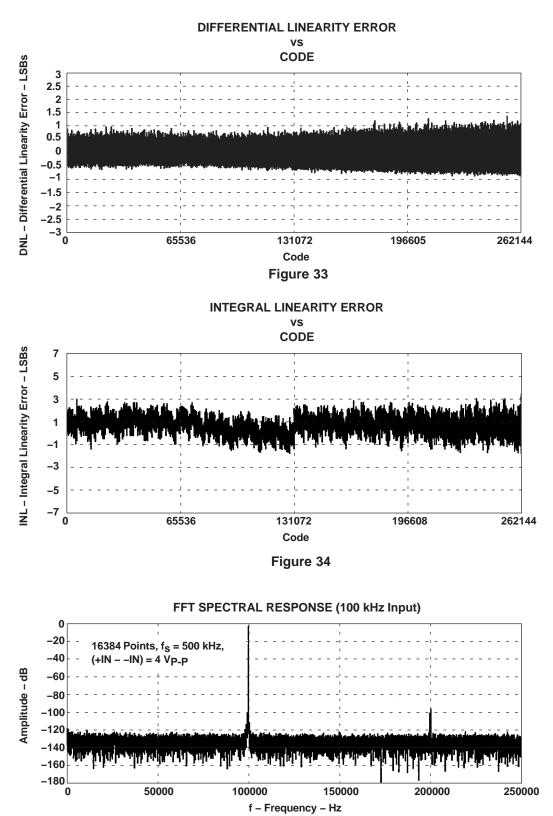




[†] At -40°C to 85°C, +VA = 5 V, +VBD = 5 V, REFIN = 4.096 V and f_{sample} = 500 kHz (unless otherwise noted)



TYPICAL CHARACTERISTICS[†]





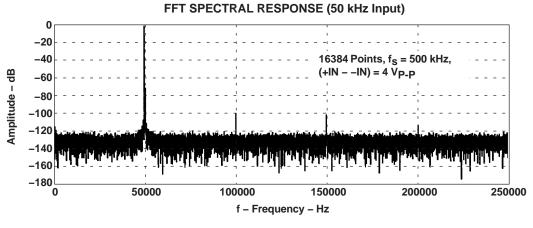


Figure 36



APPLICATION INFORMATION

MICROCONTROLLER INTERFACING

ADS8383 to 8-Bit Microcontroller Interface

Figure 37 shows a parallel interface between the ADS8383 and a typical microcontroller using the 8-bit data bus.

The BUSY signal is used as a falling-edge interrupt to the microprocessor.

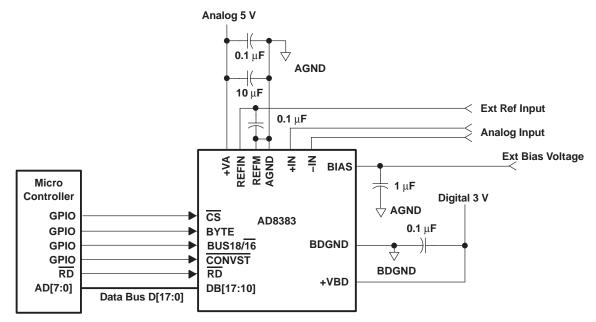


Figure 37. ADS8383 Application Circuitry

PRINCIPLES OF OPERATION

The ADS8383 is a high-speed successive approximation register (SAR) analog-to-digital converter (ADC). The architecture is based on charge redistribution which inherently includes a sample/hold function. See Figure 37 for the application circuit for the ADS8383.

The conversion clock is generated internally. The conversion time of 1.52 μ s is capable of sustaining a 500-kHz throughput.

The analog input is provided to two input pins: +IN and –IN. When a conversion is initiated, the differential input on these pins is sampled on the internal capacitor array. While a conversion is in progress, both inputs are disconnected from any internal function.

REFERENCE

The ADS8383 can operate with an external 4.096-V reference for a corresponding full-scale range of 4.096 V. **BIASING THE ADS8383**

The ADS8383 requires an external 2.048-V bandgap reference to generate the bias currents for internal circuitry. Figure 38 shows the internal circuitry used to generate the bias currents. The bias generation circuit also pumps 100 μ A (150 μ A max) out from the BIAS pin. The bandgap used should be capable of sinking 100 μ A (150 μ A max) while holding the voltage on the pin steady. Table 1 shows the specification of the bandgap used to drive the BIAS pin of the ADS8383.

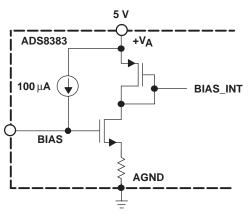


Figure 38. Bias Current Generation

Table	1.	Bias	Specifications
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PARAMETER	MIN	TYP	MAX	UNITS
Output Voltage	2	2.048	2.1	V
Isink		100	150	μA

Any common bandgap like REF3020 can be used to drive the BIAS pin of the ADS8383. Figure 39 shows how REF3020 can be used with the ADS8383. A 1 μ F decoupling capacitor is recommended between pins 2 and AGND of the ADS8383 for optimal performance.

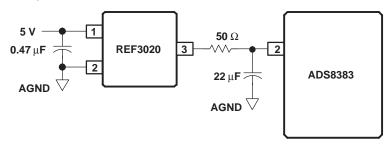


Figure 39. Using the REF3020 to Drive the ADS8383 BIAS Pin



ANALOG INPUT

When the converter enters the hold mode, the voltage difference between the +IN and –IN inputs is captured on the internal capacitor array. The voltage on the –IN input is limited between –0.2 V and 0.2 V, allowing the input to reject small signals which are common to both the +IN and –IN inputs. The +IN input has a range of –0.2 V to V_{ref} + 0.2 V. The input span (+IN – (–IN)) is limited to 0 V to V_{ref} .

The input current on the analog inputs depends upon a number of factors: sample rate, input voltage, and source impedance. Essentially, the current into the ADS8383 charges the internal capacitor array during the sample period. After this capacitance has been fully charged, there is no further input current. The source of the analog input voltage must be able to charge the input capacitance (45 pF) to an 18-bit settling level within the acquisition time (400 ns) of the device. When the converter goes into the hold mode, the input impedance is greater than 1 G Ω .

Care must be taken regarding the absolute analog input voltage. To maintain the linearity of the converter, the +IN and -IN inputs and the span (+IN - (-IN)) should be within the limits specified. Outside of these ranges, the converter's linearity may not meet specifications. To minimize noise, low bandwidth input signals with low-pass filters should be used.

Care should be taken to ensure that the output impedance of the sources driving the +IN and –IN inputs are matched. If this is not observed, the two inputs could have different setting times. This may result in offset error, gain error, and linearity error which changes with temperature and input voltage.

DIGITAL INTERFACE

Timing And Control

See the timing diagrams in the specifications section for detailed information on timing signals and their requirements.

The ADS8383 uses an internal oscillator generated clock which controls the conversion rate and in turn the throughput of the converter. No external clock input is required.

Conversions are initiated by bringing the CONVST pin low for a minimum of 20 ns (after the 20 ns minimum requirement has been met, the CONVST pin can be brought high), while CS is low. The ADS8383 switches from the sample to the hold mode on the falling edge of the CONVST command. A clean and low jitter falling edge of this signal is important to the performance of the converter. The BUSY output is brought high immediately following CONVST going low. BUSY stays high through the conversion process and returns low when the conversion has ended.

Sampling starts with the falling edge of the BUSY signal when \overline{CS} is tied low or starts with the falling edge of \overline{CS} when BUSY is low.

Both $\overline{\text{RD}}$ and $\overline{\text{CS}}$ can be high during and before a conversion with one exception ($\overline{\text{CS}}$ must be low when $\overline{\text{CONVST}}$ goes low to initiate a conversion). Both the $\overline{\text{RD}}$ and $\overline{\text{CS}}$ pins are brought low in order to enable the parallel output bus with the conversion.

Reading Data

The ADS8383 outputs full parallel data in straight binary format as shown in Table 2. The parallel <u>output is</u> active when CS and RD are both low. There is a minimal quiet zone requirement around the falling edge of CONVST. This is 125 ns prior to the falling edge of CONVST and 40 ns after the falling edge. No data read should be attempted within this zone. Any other combination of CS and RD sets the parallel output to 3-state. BYTE and BUS18/16 are used for multiword read operations. BYTE is used whenever lower bits on the bus are output on the higher byte of the bus. BUS18/16 is used whenever the last two bits on the 18-bit bus is output on either bytes of the higher 16-bit bus. Refer to Table 2 for ideal output codes.

	2002 – REVISED FEBRUAR	V 2005
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DESCRIPTION	ANALOG VALUE				
Full scale range	+V _{ref}	DIGITAL OUTPUT STRAIGHT BINARY			
Least significant bit (LSB)	+V _{ref} /262144	BINARY CODE	HEX CODE		
Full scale	+V _{ref} -1LSB	11 1111 1111 1111 1111	3FFFF		
Midscale	+V _{ref} /2	10 0000 0000 0000 0000	20000		
Midscale – 1 LSB	+V _{ref} /2 – 1 LSB	01 1111 1111 1111 1111	1FFFF		
Zero	0 V	00 0000 0000 0000 0000	00000		

Table 2. Ideal Input Voltages and Output Codes

The output data is a full 18-bit word (D17–D0) on DB17–DB0 pins (MSB–LSB) if both BUS18/16 and BYTE are low.

The result may also be read on a 16-bit bus by using only pins DB17–DB2. In this case two reads are necessary: the first as before, leaving both BUS18/16 and BYTE low and reading the 16 most significant bits (D17–D2) on pins DB17–DB2, then bringing BUS18/16 high while holding BYTE low. When BUS18/16 is high, the lower two bits (D1–D0) appear on pins DB3–DB2.

The result may also be read on an 8-bit bus for convenience. This is done by using only pins DB17–DB10. In this case three reads are necessary: the first as before, leaving both BUS18/16 and BYTE low and reading the 8 most significant bits on pins DB17–DB10, then bringing BYTE high while holding BUS18/16 low. When BYTE is high, the medium bits (D9–D2) appear on pins DB17–DB10. The last read is done by bringing BUS18/16 high while holding BYTE high. When BUS18/16 is high, the lower two bits (D1–D0) appear on pins DB11–DB10. The last read cycle is not necessary if only the first 16 most significant bits are of interest.

All of these multiword read operations can be performed with multiple active \overline{RD} (toggling) or with \overline{RD} held low for simplicity. This is referred to as the AUTO READ operation. Note that \overline{RD} may not be tied to BDGND permanently due to the requirement of power-on initialization.

5)/75	BUS18/16	DATA READ OUT							
BYTE		DB17-DB12 PINS	DB11-DB10 PINS	DB9-DB4 PINS	DB3-DB2 PINS	DB1-DB0 PINS			
High	High	All One's	D1-D0	All One's	All One's	All One's			
Low	High	All One's	All One's	All One's	D1-D0	All One's			
High	Low	D9-D4	D3-D2	All One's	All One's	All One's			
Low	Low	D17-D12	D11-D10	D9-D4	D3-D2	D1-D0			

Table 3. Conversion Data Read Out

INITIALIZATION

At first power on there are three conversion cycles required. If an ANT conversion cycle is attempted before the intialization is completed, the first three conversion cycles will not produce valid results. These are used to load factory trimming data for a specific device to ensure high accuracy of the converter. Because of this requirement, the RD pin cannot be tied permanently to BDGND. System designers can still achieve the AUTO READ function if the power-on requirement is satisfied.

LAYOUT

For optimum performance, care should be taken with the physical layout of the ADS8383 circuitry.

As the ADS8383 offers single-supply operation, it will often be used in close proximity with digital logic, microcontrollers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult it is to achieve good performance from the converter.

The basic SAR architecture is sensitive to glitches or sudden changes on the power supply, reference, ground connections and digital inputs that occur just prior to latching the output of the analog comparator. Thus, driving any single conversion for an n-bit SAR converter, there are at least n *windows* in which large external transient voltages can affect the conversion result. Such glitches might originate from switching power supplies, nearby digital logic, or high power devices.

The degree of error in the digital output depends on the reference voltage, layout, and the exact timing of the external event.

On average, the ADS8383 draws very little current from an external reference as the reference voltage is internally buffered. If the reference voltage is external and originates from an op amp, make sure that it can drive the bypass capacitor or capacitors without oscillation. A 0.1- μ F bypass capacitor is recommended from pin 1 (REFIN) directly to pin 48 (REFM). REFM and AGND should be shorted on the same ground plane under the device.

The AGND and BDGND pins should be connected to a clean ground point. In all cases, this should be the analog ground. Avoid connections which are too close to the grounding point of a microcontroller or digital signal processor. If required, run a ground trace directly from the converter to the power supply entry point. The ideal layout consists of an analog ground plane dedicated to the converter and associated analog circuitry.

As with the AGND connections, +VA should be connected to a 5-V power supply plane or trace that is separate from the connection for digital logic until they are connected at the power entry point. Power to the ADS8383 should be clean and well bypassed. A 0.1- μ F ceramic bypass capacitor should be placed as close to the device as possible. See Table 4 for the placement of the capacitor. In addition, a 1- μ F to 10- μ F capacitor is recommended. In some situations, additional bypassing may be required, such as a 100- μ F electrolytic capacitor or even a Pi filter made up of inductors and capacitors—all designed to essentially low-pass filter the 5-V supply, removing the high frequency noise.

POWER SUPPLY PLANE		CONVERTER DIGITAL SIDE	
SUPPLY PINS	CONVERTER ANALOG SIDE		
Pin pairs that require shortest path to decoupling capacitors	(4,5), (8,9), (10,11), (13,15), (43,44), (45,46)	(24,25)	
Pins that require no decoupling	12, 14	37	

Table 4. Power Supply Decoupling Capacitor Placement

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PACKAGING INFORMATION

RUMENTS

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
ADS8383IBPFBR	ACTIVE	TQFP	PFB	48		TBD	Call TI	Call TI
ADS8383IBPFBRG4	ACTIVE	TQFP	PFB	48		TBD	Call TI	Call TI
ADS8383IBPFBT	ACTIVE	TQFP	PFB	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
ADS8383IBPFBTG4	ACTIVE	TQFP	PFB	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
ADS8383IPFBR	ACTIVE	TQFP	PFB	48		TBD	Call TI	Call TI
ADS8383IPFBRG4	ACTIVE	TQFP	PFB	48		TBD	Call TI	Call TI
ADS8383IPFBT	ACTIVE	TQFP	PFB	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
ADS8383IPFBTG4	ACTIVE	TQFP	PFB	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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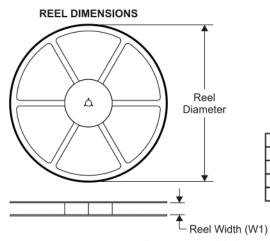
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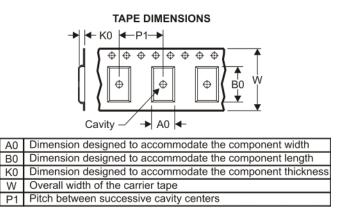
PACKAGE MATERIALS INFORMATION

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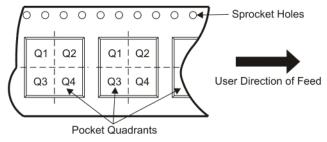
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADS8383IBPFBT	TQFP	PFB	48	250	330.0	16.4	9.6	9.6	1.5	12.0	16.0	Q2
ADS8383IPFBT	TQFP	PFB	48	250	330.0	16.4	9.6	9.6	1.5	12.0	16.0	Q2

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

29-Jul-2009



*All dimensions are nominal

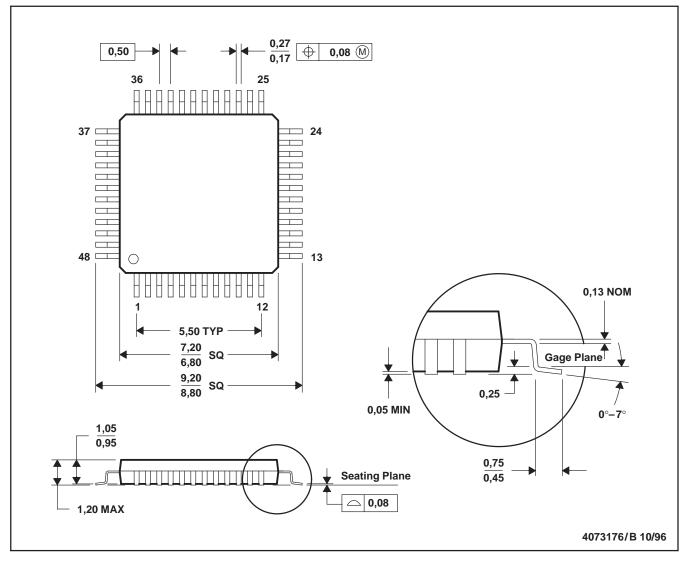
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADS8383IBPFBT	TQFP	PFB	48	250	346.0	346.0	33.0
ADS8383IPFBT	TQFP	PFB	48	250	346.0	346.0	33.0

MECHANICAL DATA

MTQF019A - JANUARY 1995 - REVISED JANUARY 1998

PFB (S-PQFP-G48)

PLASTIC QUAD FLATPACK

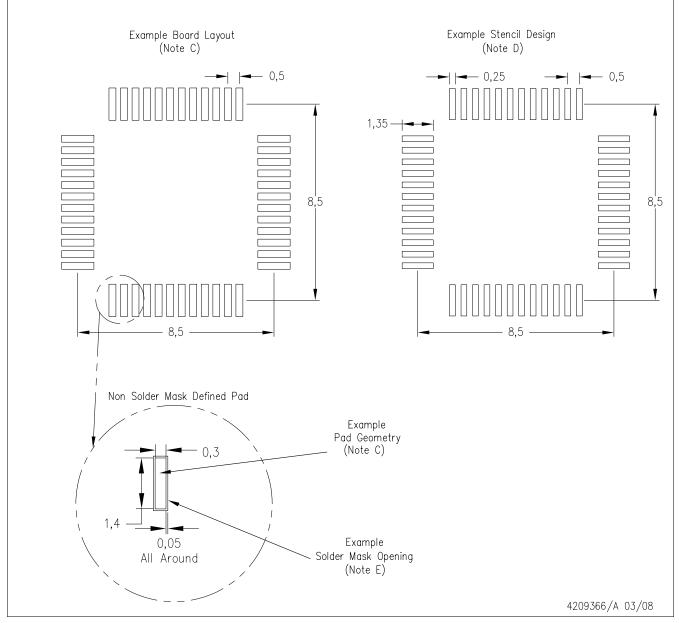


NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-026



PFB (S-PQFP-G48)



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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